

# UNISONIC TECHNOLOGIES CO., LTD

02N150-P Preliminary Power MOSFET

# 200mA, 1500V N-CHANNEL POWER MOSFET

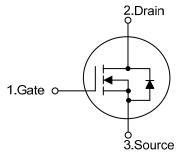
### **■** DESCRIPTION

The UTC **02N150-P** provide excellent  $R_{DS(ON)}$ , low gate charge and operation with low gate voltages. This device is suitable for use as a load switch or in PWM applications.

### **■** FEATURES0

- \*  $R_{DS(ON)} \le 65 \Omega @ V_{GS} = 10V, I_D = 0.1A$
- \* Low Reverse Transfer Capacitance
- \* Fast Switching Capability
- \* Avalanche Energy Specified
- \* Improved dv/dt Capability, High Ruggedness



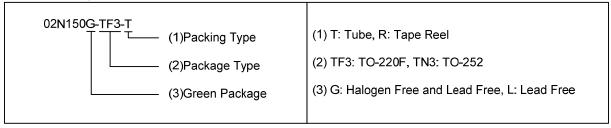


# TO-220F TO-252

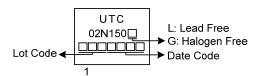
### ORDERING INFORMATION

Ordering Number		Doolsono	Pin Assignment			Deeking	
Lead Free	Halogen Free	Package	1	2	3	Packing	
02N150L-TF3-T	02N150G-TF3-T	TO-220F	G	D	S	Tube	
02N150L-TN3-R	02N150G-TN3-R	TO-252	G	D	S	Tape Reel	

Note: Pin Assignment: G: Gate D: Drain S: Source



# MARKING



<u>www.unisonic.com.tw</u> 1 of 6

# ■ **ABSOLUTE MAXIMUM RATINGS** (T<sub>C</sub>=25°C, unless otherwise specified)

PARAMETER		SYMBOL	RATINGS	UNIT	
Drain-Source Voltage		$V_{ t DSS}$	1500	V	
Gate-Source Voltage		$V_{GSS}$	±30	V	
Drain Current	Continuous	I <sub>D</sub>	0.2	Α	
	Pulsed (Note 2)	I <sub>DM</sub> 0.4		Α	
Peak Diode Recovery dv/dt (Note 3)		dv/dt	2.2	V/ns	
Power Dissipation	TO-220F	Б	12	W	
	TO-252	$P_D$	20	W	
Junction Temperature		$T_J$	+150	°C	
Storage Temperature		T <sub>STG</sub>	-55 ~ <b>+</b> 150	°C	

Notes: 1. Absolute maximum ratings are those values beyond which the device could be permanently damaged. Absolute maximum ratings are stress ratings only and functional device operation is not implied.

- 2. Repetitive Rating: Pulse width limited by maximum junction temperature.
- 3.  $I_{SD} \le 1.0 A$ , di/dt  $\le 200 A/\mu s$ ,  $V_{DD} \le BV_{DSS}$ , Starting  $T_J = 25 ^{\circ}C$

# ■ THERMAL DATA

PARAMETER		SYMBOL	RATING	UNIT	
Junction to Ambient	TO-220F	0	62.5	°C/W	
	TO-252	θ <sub>JA</sub>	110	°C/W	
Junction to Case	TO-220F	0	10.4	°C/W	
	TO-252	θ <sub>JC</sub>	6.25 (Note)	°C/W	

Note: Device mounted on FR-4 substrate P<sub>C</sub> board, 2oz copper, with 1inch square copper plate.

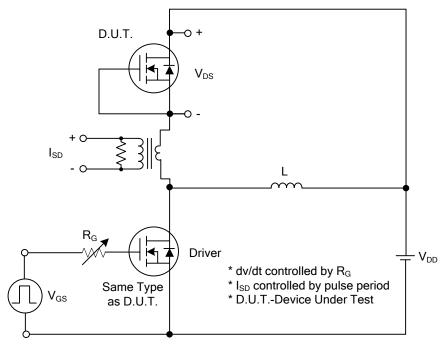
# ■ **ELECTRICAL CHARACTERISTICS** (T<sub>J</sub>=25°C, unless otherwise specified)

PARAMETER	SYMBOL	TEST CONDITIONS	MIN	TYP	MAX	UNIT			
OFF CHARACTERISTICS									
Drain-Source Breakdown Voltage	$BV_{DSS}$	$V_{GS}$ =0V, $I_{D}$ =250 $\mu$ A	1500			V			
Drain-Source Leakage Current	$I_{DSS}$	V <sub>DS</sub> =1500V, V <sub>GS</sub> =0V			10	μΑ			
Gate-Source Leakage Current	$I_{GSS}$	$V_{GS}$ =±30V, $V_{DS}$ =0V			±100	nΑ			
ON CHARACTERISTICS									
Gate Threshold Voltage	$V_{GS(TH)}$	$V_{DS}=V_{GS}$ , $I_D=250\mu A$	2.0		4.0	V			
Static Drain-Source On-State Resistance	R <sub>DS(ON)</sub>	V <sub>GS</sub> =10V, I <sub>D</sub> =0.1A			65	Ω			
DYNAMIC CHARACTERISTICS									
Input Capacitance	$C_{ISS}$			176		pF			
Output Capacitance	Coss	V <sub>DS</sub> =25V, V <sub>GS</sub> =0V, f=1MHz		25		pF			
Reverse Transfer Capacitance	$C_{RSS}$			3.2		pF			
SWITCHING CHARACTERISTICS									
Total Gate Charge (Note 1)	$Q_G$	V <sub>DS</sub> =1200V, V <sub>GS</sub> =10V, -I <sub>D</sub> =0.2A, (Note 1, 2)		12.5		nC			
Gate-Source Charge	$Q_GS$			5.2		nC			
Gate-Drain Charge	$Q_GD$			2.1		nC			
Turn-On Delay Time (Note 1)	$t_{D(ON)}$	$-V_{DD}$ =100V, $V_{GS}$ =10V, $I_{D}$ =0.2A, $-R_{G}$ =25 $\Omega$ (Note 1, 2)		6		ns			
Turn-On Rise Time	$t_R$			17		ns			
Turn-Off Delay Time	t <sub>D(OFF)</sub>			40		ns			
Turn-Off Fall Time	$t_{F}$			180		ns			
SOURCE- DRAIN DIODE RATINGS AND CHA	ARACTERIST	rics							
Maximum Continuous Drain-Source Diode					0.2	Α			
Forward Current	I <sub>S</sub>				0.2	А			
Maximum Pulsed Drain-Source Diode	1				0.4	Α			
Forward Current	I <sub>SM</sub>				0.4	А			
Drain-Source Diode Forward Voltage (Note 1)	$V_{SD}$	I <sub>S</sub> =0.2A, V <sub>GS</sub> =0V			1.4	V			
Body Diode Reverse Recovery Time (Note 1)	t <sub>rr</sub>	I <sub>S</sub> =0.2A, V <sub>GS</sub> =0V,		630		ns			
Body Diode Reverse Recovery Charge	$Q_{rr}$	dI <sub>F</sub> /dt=100A/μs		840		nC			

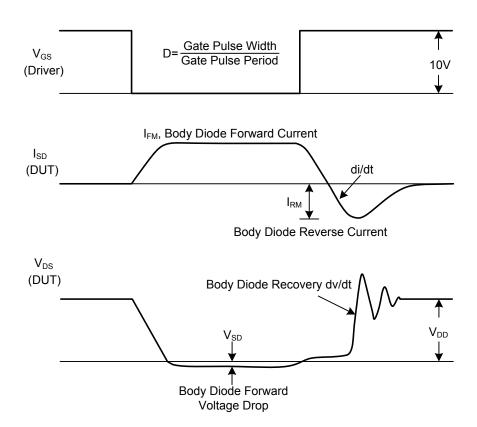
Notes: 1. Pulse Test: Pulse width  $\leq$  300 $\mu$ s, Duty cycle  $\leq$  2%.

<sup>2.</sup> Essentially independent of operating temperature.

# ■ TEST CIRCUITS AND WAVEFORMS

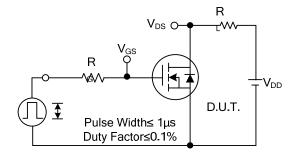


Peak Diode Recovery dv/dt Test Circuit

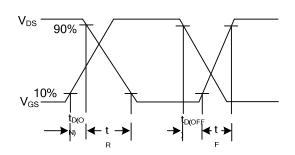


Peak Diode Recovery dv/dt Waveforms

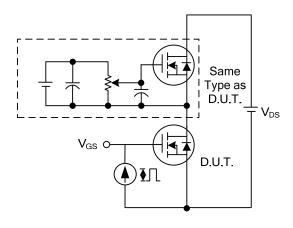
# **■ TEST CIRCUITS AND WAVEFORMS**



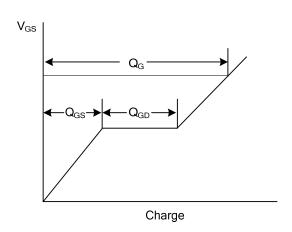
**Switching Test Circuit** 



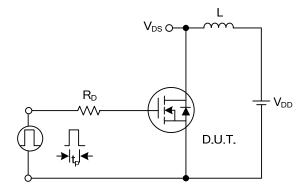
Switching Waveforms



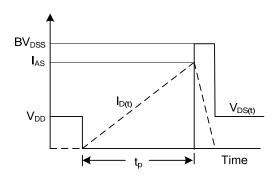
Gate Charge Test Circuit



Gate Charge Waveform



Unclamped Inductive Switching Test Circuit



**Unclamped Inductive Switching Waveforms** 

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